I Introduction

• Pop. mean is $\mu = \omega_1 \mu_1 + \cdots + \omega_k \mu_k$ & pop. var. Std. nor. distr. N(0,1) has cum. distr. fn. is $\sigma^2 = \overline{\sigma^2} + \sum_{j=1}^{\infty} \omega_j (\mu_j - \mu)^2$ $\phi(z) = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^{z} e^{-y^2/2} dy$

• If we pick at random one element from the pop., then its value x is a realisation of a random

var. X whose distr. is the pop. distr. • Pop. mean $\mu = E(X) = \frac{1}{N} \sum x_i$ & pop. std. dev.

II Random sampling

$\sigma = \sqrt{Var(X)}$ & pop.tot $\tau = \sum_{i} x_i = N\mu$

• Prob. distr. curve depends on estimating μ &

S.O.R produces a simple random sample.S.W.R produces an I.I.D sample. 1. Point estimation

• Sampling distribution has mean
$$\mu_{\hat{\Theta}} = E(\hat{\Theta})$$
 and var. $\sigma_{\hat{\Theta}}^2 = E(\hat{\Theta} - \mu_{\hat{\Theta}})^2$.

2. Sample mean and sample variance • Sample mean $\bar{x} = \frac{1}{n} \sum_{i=1}^{n} x_i$ & sample std. dev.

 $s^2 = \frac{1}{n-1} \sum_{i=1}^{n} (x_i - \bar{x})^2 = \frac{n}{n-1} (\overline{x^2} - \overline{x}^2)$ Independent and identically distributed(I.I.D) sample: sample mean \bar{x} and sample var s^2 are unbiased estimators for the pop. mean μ

 σ^2 , $Var(S^2) = \frac{\sigma^4}{n} (E(\frac{X-\mu}{\sigma})^4 - \frac{n-3}{n-1})$ • Dichotomous case: sample mean turns into a sample proportion $\hat{p} = \hat{x}$ giving an unbiased estimate of p $\mu = p, \sigma^2 = p(1-p)$ • Estimated standard errors for the sample mean

and var $\sigma^2 E(\bar{X}) = \mu, Var(\bar{X}) = \frac{\sigma^2}{n}, E(S^2) =$

and proportion $s_{\bar{x}} = \frac{s}{\sqrt{n}} \& s_{\hat{p}} = \sqrt{\frac{\hat{p}(1-\hat{p})}{n-1}}$ • Simple random sampling(S.R.S): sample mean \bar{x} is an unbiased estimate for pop. mean μ & sample var. s^2 is a biased estimate of σ^2

 $E(S^2) = \sigma^2 \frac{N}{N-1} \& Var(\bar{X}) = \frac{\sigma^2}{n} (1 - \frac{n-1}{N-1})$. Unbiased estimate of $Var(\bar{X})$ is $s_{\bar{x}}^2 = \frac{s^2}{n}(1 - \frac{n}{N})$ • Sampling without replacement(S.O.R): estimated standard errors $s_{\bar{x}} = \frac{s}{\sqrt{n}} \sqrt{1 - \frac{n}{N}}$ &

3. Approximate confidence intervals • By the Central Limit Theorem, the sample

mean distr. is approx. normal $\bar{X} \approx N(\mu, \frac{\sigma^2}{n})$ in that for large sample sizes n, we have $P(|\frac{X-\mu}{\sigma_{\bar{X}}}| > z) \approx 2(1-\phi(z))$. Since $S_{\bar{X}} \approx \sigma_{\bar{X}}$, $L(p) = {n \choose r} p^x (1-p)^{n-x}$. Log-likelihood function we have $P(\bar{X} - zS_{\bar{X}} < \mu < \bar{X} + zS_{\bar{X}}) =$ is $l(p) = \ln L(p)$. Then l'(p) = 0 gives MLE of pop.

 $P(|\frac{X-\mu}{\sigma_x}| > z) \approx 2(1-\phi(z))$. This yields the formula of $100(1-\alpha)\%$ 2-sided c.i for $\mu \& p: I_{\mu} = \bar{x} \pm z_{\alpha/2} s_{\bar{x}}, I_{p} = \hat{p} \pm z_{\alpha/2} s_{\hat{p}}.$

• $100(1-\alpha)\%$ c.i for μ means $100(1-\alpha)\%$ are expected to cover the true value of μ . Higher the confidence level, the wider is confidence interval. Larger the sample, the narrower is confidence interval.

4. Stratified random sampling • Strat. prop. for each strat. j, j=1,...,k is $\omega_i = \frac{N_j}{N}$

s.t. $\omega_1 + \cdots + \omega_k = 1$

• Stratified sample mean is $\overline{x}_s = \omega_1 \overline{x}_1 + \cdots +$ $\omega_k \overline{x}_k$ where $\overline{x}_i = \text{est. of sample mean of sample}$

size n_i for each strat. • Var. of \overline{X}_s is $Var(\overline{X}_s) = \sigma_{\overline{X}_s}^2 = \frac{\omega_1^2 \sigma_1^2}{n_1} + \dots + \frac{\omega_k^2 \sigma_k^2}{n_k}$ • Opt. alloc. is $n_i = \frac{n\omega_j\sigma_j}{\overline{\sigma}}$ where $\sigma_i = \text{sample}$ find $\tilde{\theta} = \frac{1}{\bar{x}}$. Likelihood fn. $L(\theta) = \theta^n e^{-\theta(x_1 + \dots + x_n)}$. std. dev. of sample size n_i for each strat. j &

 $\overline{\sigma} = \omega_1 \sigma_1 + \dots + \omega_k \sigma_k \& n = tot.$ sample size • Prop. alloc. is $\overline{n}_i = n\omega_i$ • Var. of est. of pop. mean obtd using s.r.s is $Var(\overline{X}) = \frac{\sigma^2}{n}$ • Var. of est. of pop. mean obtd using prop. alloc is $Var(\overline{X}_{sp}) = \frac{\overline{\sigma^2}}{n}$ where $\overline{\sigma^2} = \omega_1 \sigma_1^2 + \dots + \omega_k \sigma_k^2$

• Var. of est. of pop. mean obtd using opt. alloc. is $Var(\overline{X}_{so}) = \frac{\overline{\sigma}^2}{r}$ $\bullet \ Var(\overline{X}) \geq Var(\overline{X}_{sp}) \geq Var(\overline{X}_{so})$ • Approx. c.i. $I_{\mu} = \overline{x}_s \pm z_{\alpha/2} s_{\overline{x}_s}$

III Parameter estimation

Suppose an iid-sample from a pop. distr. is characterised by a pair of parameters (θ_1, θ_2) . Sup-

1. Method of moments

pose we have the foll. formulas for the 1st and 2nd pop. moments: $E(X) = f(\theta_1, \theta_2)$, $E(X^2) =$ $g(\theta_1, \theta_2)$. M.O.M est. $(\tilde{\theta}_1, \tilde{\theta}_2)$ are found after replacing the pop. moments with the corr. sample moments, and solving the obtained eqns $\bar{x} =$ $f(\tilde{\theta}_1, \tilde{\theta}_2), \ \bar{x^2} = g(\tilde{\theta}_1, \tilde{\theta}_2)$. This approach is justified by the Law of Large Numbers $\frac{X_1 + \dots + X_n}{n} \to \mu$, $\frac{X_1^2 + \dots + X_n^2}{n} \to E(X^2), n \to \infty.$

apply m.o.m est. formula are $\hat{\alpha} = \frac{\hat{\mu}^2}{\hat{\alpha}^2} \& \hat{\lambda} = \frac{\hat{\mu}}{\hat{\alpha}^2}$ • Geometric model- m.o.m est. for para. $\theta = p$ is $\bar{x} = \frac{1}{\bar{p}}$, approx. c.i. for p is $I_p = \frac{1}{\bar{x} \pm z_{\alpha/2} s_{\bar{x}}}$, obs. $\hat{\mu} = \overline{X} = \frac{1}{n} \sum_{i=1}^{n} X_{i} \& \hat{\sigma}^{2} = \frac{1}{n} \sum_{i=1}^{n} X_{i}^{2} - \overline{X}^{2}$. If we freq. given, exptd. freq.= $n(1-\tilde{p})^{j-1}\tilde{p}$ 2. Maximum likelihood estimation • In a parametric setting, given a parameter value θ , the observed sample (x_1, \dots, x_n) is a

realisation of the random vector (X_1, \dots, X_n) which has a certain joint distr. $f(y_1, \dots, y_n | \theta)$ as a fn. of possible values (y_1, \dots, y_n) . Fixing the variables $(y_1, \dots, y_n) = (x_1, \dots, x_n)$ and allowing the parameter value θ to vary, we obtain the likelihood fn. $L(\theta) = f(x_1, ... x_n | \hat{\theta})$. The maximum • Diff. betwn. parametric & nonparametric likelihood estimate $\hat{\theta}$ of θ is the value of θ that maximises $L(\theta)$. • Example: binomial model- n obs. $X \sim$ Bin(n,p). From $\mu = np$, m.o.m est. $\tilde{p} = \frac{x}{n}$ is the sample proportion. Likelihood fn.is

prop. is the sample prop. $\hat{p} = \frac{x}{n}$ 3. Sufficiency • Example: Bernoulli distr.-For 1 Ber. trial,

 $f(x) = P(X = x) = p^{x}(1-p)^{1-x}, x \in \{0,1\}$ and for n Ber. trials, $f(x_1, \dots, x_n|p) =$ $\prod_{i=1}^{n} p^{x_i} (1-p)^{1-x_i} = p^{n\bar{x}} (1-p)^{n-n\bar{x}}$. Thus for Ber. model, no. of successes $t = x_1 + \dots + x_n = n\bar{x}$ is a suff. statistic whose distr. is $T \sim Bin(n, p)$. • Example: Normal distr.- Nor. distr. mo-

del $N(\mu, \sigma^2)$ has 2-D sufficient statistic $(t_1, t_2), t_1 = \sum_{i=1}^n x_i, t_2 = \sum_{i=1}^n x_i^2$ which follows from $L(\mu, \sigma) = \prod_{i=1}^{n} \frac{1}{\sqrt{\sigma}} e^{-\frac{(x_i - \mu)^2}{2\sigma^2}} =$

 $(1/\sigma^n(2\pi)^{n/2})e^{-rac{t_2-2\mu t_1+n\mu^2}{2\sigma^2}}$ 4. Large sample prop. of the m.l.e • Normal approx. $\hat{\Theta} \approx N(\theta, \frac{1}{nI(\theta)})$. Let

 $g(x,\theta) = \frac{\partial^2 \ln f(x|\theta)}{\partial \theta^2}$ & Fisher information $I(\theta) = -E[g(X, \theta)] = -\int g(x, \theta) f(x|\theta) dx$. Approx. $100(1-\alpha)\%$ c.i. $I_{\theta} = \hat{\theta} \pm z_{\frac{\alpha}{2}} \frac{1}{\sqrt{nI(\theta)}}$ • Example: exponential model- From $\mu = \frac{1}{4}$, we

For exp. model, $t = x_1 + \cdots + x_n$ is a suff. statistic & M.L.E is $\hat{\theta} = \frac{1}{\bar{z}}$ 5. Gamma distribution • Den. fn of Gamma distr. is $f(x|\alpha,\lambda) =$ $\frac{1}{\Gamma(\alpha)}\lambda^{\alpha}x^{\alpha-1}e^{-\lambda x}$, $0 \le x < \infty$ where shape parameter $\alpha > 0$ and scale parameter $> 0. (t_1, t_2) = (x_1 + \cdots + x_n, x_1 \cdots x_n)$ is pair of sufficient statistics. Likelihood fn. is $L(\alpha, \lambda) = \prod_{i=1}^{n} \frac{1}{\Gamma(\alpha)} \lambda^{\alpha} x_i^{\alpha-1} e^{-\lambda x_i}$. Log likelihood of i.i.d sample is $l(\alpha, \lambda) =$

Partial der. are $\frac{\partial l}{\partial \alpha} = n \ln \lambda + \sum_{i=1}^{n} \ln x_i - n \frac{\Gamma'(\alpha)}{\Gamma(\alpha)}$ $\frac{\partial l}{\partial \lambda} = \frac{n\alpha}{\lambda} - \sum_{i=1}^{n} x_{i}$. Setting these to 0, $\hat{\lambda} = \frac{\hat{\alpha}}{x}$, $n \ln \hat{\alpha} - n \ln \overline{x} + \sum_{i=1}^{n} \ln x_i - n \frac{\Gamma'(\hat{\alpha})}{\Gamma(\hat{\alpha})} = 0$. Eqns. cannot be solved in closed form and \therefore we use iter. meth. for finding the roots where the intial val. obtd.

• Parametric bootstrap- For initial values, we

by m.o.m est.

hypothesis that: $\operatorname{div}(A \cap Z_{obs}) = Z_0 \operatorname{prime}(B)$ which is $P = P(Z > z) = 1 - \phi(z)$ and in terms of the random variables $P = P(Z > Z_{obs}) = 1 - \phi(Z_{obs})$.

• Under H_0 , $P(P > p) = P(1 - \phi(Z_{obs}) > 1 - \phi(z)) = P(\phi(Z_{obs}) < \phi(z)) = P(Z_{obs} < z) = \phi(z) = 1 - p \dots P$ -value has uniform null distr. could simulate from the true population distribution $Gam(\alpha, \lambda)$, then B samples of size n 2. Large-sample test for the proportion would generate B independent estimates $\hat{\alpha}_i$. Then the standard deviation of the sampling distribution would give us the desired std. err. $s_{\hat{\alpha}} = \sqrt{\frac{1}{B} \sum_{j=1}^{B} (\hat{\alpha}_j - \overline{\alpha})^2}, \, \overline{\alpha} = \frac{1}{B} \sum_{j=1}^{B} \hat{\alpha}_j$

bootstrap- In parametric bootstrap, we have a known (assumed) distr. $l(\theta)$ with unknown parameter θ . We estimate θ by $\hat{\theta}$ and draw samples from the distr. $l(\hat{\theta})$. In non-parametric bootstrap, we do not assume an underlying distr and instead resample from the set of original samples x_1, \dots, x_n . Bootstrap is a resampling technique used to study the sampling distribution of a para-

meter estimator. In the parametric bootstrap resampling is done from the given parametric distribution with the unknown parameters replaced by their estimates obtained from the underlying sample. In the non-parametric bootstrap resampling is performed with replacement directly from the the underlying sample. 6. Exact confidence intervals

• t-distribution: $\frac{\bar{X}-\mu}{S_{\bar{X}}} \sim t_{n-1}$ • Exact 100 $(1-\alpha)\%$ c.i. for mean: $I_{\mu} =$

 $\bar{x} \pm t_{n-1}(\alpha/2)s_{\bar{x}}$

• A rule based on data for choosing between 2 mutually exclusive hypotheses

 $\left(\frac{(n-1)s^2}{\chi^2_{n-1}(\alpha/2)}, \frac{(n-1)s^2}{\chi^2_{n-1}(1-\alpha/2)}\right)$

1. Statistical significance

null hypothesis H_0 : effect of interest is zero, alternative H_1 : effect of interest is not zero. A decision rule for hypotheses testing is based

• chi-squared distribution: $\frac{(n-1)S^2}{\sigma^2} \sim \chi_{n-1}^2$

• Exact 100 $(1-\alpha)\%$ c.i. for var: I_{σ^2}

IV Hypothesis testing

on a test statistic $t = t(x_1, \dots, x_n)$, a fn. of the data with distinct typical values under H_0 & H_1 . The task is to find an appropriately chosen rejection region R and reject H_0 in favor of H_1 if and only if $t \in \mathbb{R}$. • Four imp condn. prob.significance level/type I error- $\alpha = P(T \in R|H_0)$ specificity of the test- $1-\alpha = P(T \notin R|H_0)$, type II error- $\beta = P(T \notin R|H_1)$ sensitivity or power-1 $-\beta = \tilde{P}(T \in R|H_1)$

 $\sum [\alpha \ln \lambda + (\alpha - 1) \ln x_i - \lambda x_i - \ln \Gamma(\alpha)]$ type II error is the failure to reject a false null hypothesis (also known as a false negative $= n\alpha \ln \lambda + (\alpha - 1) \sum_{i=1}^{n} \ln x_i - \lambda \sum_{i=1}^{n} x_i - n \ln \Gamma(\alpha).$ • A significance level is a pre-decided limit for when we reject the null hypothesis. A p-valué is the probability of obtaining a test statistic value as extreme or more extreme than the observed one, given that H_0 is true. For given α , reject H_0 , if p-value $\leq \alpha$, and do not reject H_0 , if p-value $> \alpha$. Observe that the p-value depends on the data and therefore, is a likelihood ratio as test statistic- $\Lambda = \frac{L(\theta_0)}{L(\theta_1)}$. Large realisation of a random variable P. The source of randomness is in the sampling procedure: if vou take another sample, vou obtain a different p-value. To illustrate, suppose we are testing $H_0: \theta = \theta_0$ vs. $H_1: \theta > \theta_0$. Suppose the null

hypothesis is true. Given $z_{obs} = z$, p-value is

known as a false positive outcome), while a

Bin model X ~ Bin(n,p). sample prop. $\hat{p} = \frac{x}{n}$ alternative hypotheses: 1-sided H_1 : $p > p_0$, 1-sided H_1 : $p < p_0$, 2-sided H_1 : $p \neq p_0$. Alter. H_1 Rej. rule P-value $P(Z \ge z_{obs})$ $p > p_0$ $z \ge z_{\alpha}$ $P(Z \leq z_{obs})$ $p < p_0$ $z \leq -z_{\alpha}$ $z \le -z_{\alpha/2}$ or $z \ge z_{\alpha/2} \mid 2P(Z \ge |z_{obs}|)$ • Power function- Consider two simple hypo-

theses H_0 : $p = p_0 \& H_1$: $p = p_1$ assuming

 $p_1 > p_0$. The null distribution of Y is approxi-

Chi-squared test statistic $\chi^2 = \sum_{i=1}^{J} \frac{(O_j - E_j)^{i}}{E_i}$ mately normally distributed with parameters $(np_0, np_0(1-p_0))$. At the significance level α , the rejection region for the one-sided alternative is $\frac{X-np_0}{\sqrt{np_0(1-p_0)}} \ge z_a$. The power function of the one-sided test can be computed using the normal approximation for $\frac{X-np_1}{\sqrt{np_1(1-p_1)}}$

der H_1 : $Pw(p_1) = P(\frac{X - np_0}{\sqrt{np_0(1-p_0)}} \ge z_\alpha | H_1) =$ $\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{m}|H_1|$

 $-\phi(\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{2})$, Now, since under the alternative hypothesis X approximately normally distributed

which gives the formula for sample size $\sqrt{n} = \frac{z_{\alpha}\sqrt{p_0(1-p_0)} + z_{\beta}\sqrt{p_1(1-p_1)}}{2}$

with parameters (np_1, np_1q_1) ,

the equation $\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{\sqrt{n}}$

 $\phi(\frac{z_{\alpha}\sqrt{p_0(1-p_0)}+\sqrt{n}(p_0-p_1)}{p_0})$. This leads to

• If the alternatives are very close to each other, the denominator tends to zero and hence the sample size becomes very large. • If we decrease the levels α and β , the values

 z_{α} and z_{β} from the normal distribution table become larger and the sample size will be larger as well. If we want to have more control over

both types of errors, we have to collect more 3. Small-sample test for the proportion • For small n, we use exact null distribution $X \sim$

 $Bin(n, p_0). P(X \ge x) = \sum_{i=x}^{n} {n \choose i} p_0^{j} (1 - p_0)^{n-j}$ 4. Two tests for the mean • In statistical hypothesis testing, a type I error is the rejection of a true null hypothesis (also

· Large-sample test for mean- pop. distr. is not necessarily normal- sample size n is sufficiently large-compute the rejection region using an approximate null distr. $T \approx^{H_0} N(0,1)$ • One-sample t-test-pop. distr. is normal-small n-compute the rejection region using an exact

null distr. $T \sim^{H_0} t_{n-1}$ • C.I. method of hypotheses testing- at sig. level α , rejection rule is $R = \{\mu_0 \notin I_{\mu}\}$. Reject H_0 : $\mu = \mu_0$ if the interval does not cover val. of μ_0 . 5. Likelihood ratio test For testing $H_0: \theta = \theta_0$ against $H_1: \theta = \theta_1$, we use

values of Λ suggest that H_0 explains the data set better than H_1 , while small Λ indicates that H_1 explains the data set better. Likelihood ratio test rejects H_0 for small values of Λ . • Neyman-Pearson lemma: the likelihood ratio

test is optimal in the case of two simple hypo-6. Pearson's chi-squared test/Goodness of fit chi-square test Suppose that each of n indep. obs. belongs

to one of J classes with prob. (p_1, \dots, p_I) . Such data are summarised as the vector of observed counts whose joint distribution is multinomial $(O_1, \dots, O_J) \sim Mn(n; p_1, \dots, p_J)$,

 $P(O_1 = k_1, \dots, O_J = k_J) = \frac{n!}{k_1! \dots k_J!} p_1^{k_1} \dots p_J^{k_J}$ Consider a parametric model for the data $H_0:(p_1,\cdots,p_I)=(v_1(\lambda),\cdots,v_I(\lambda))$ with unknown parameters $\lambda = (\lambda_1, \dots, \lambda_r)$. To see if the propo-

whose approx. null distr. is χ^2_{J-1-r} where J = no. of cells & r = no. of indep. para. estimtd. from • Example: geometric model

7. Example: sex ratio • Simple hypothesis $H_0: p_i = \binom{n}{i} 2^n$. $E_i = N p_i$

• Comp. hyp. $H_0: p_i = \binom{n}{i} \hat{p}^j (1 - \hat{p})^{n-j}$. $E_i = N p_i$

V Bayesian inference

sed model fits the data, compute $\hat{\lambda}$, the m.l.e of

 λ , and then expected cell counts $E_i = n v_i(\tilde{\lambda})$.

• Posterior distr. $h(\theta|x)$ using the Bayes formula (Bayes Probability Law) $h(\theta|x) = \frac{f(x|\theta)g(\theta)}{\phi(x)}$ where $\phi(x) = \int f(x|\theta)g(\theta)d\theta$ or $\sum_{\theta} f(x|\theta)g(\theta)$.

We consider the case of two simple hypotheses. Choose between $H_0: \theta = \theta_0 \& H_1: \theta = \theta_1$ using not only the likelihoods of the data Dirichlet distribution- Density fn. $f(x|\theta_0), f(x|\theta_1)$ but also prior probabilities $P(H_0) = \pi_0$, $P(H_1) = \pi_1$. In terms of the rejection region R the decision should be taken depending Data distr. Posterior distr. of a cost function. c_0 is the error type I cost and c_1 $N(\gamma_n \mu_0 + (1 \mu \sim N(\mu_0, \sigma_0^2)$ is the error type II cost. For a given set R, the ave- $N(\mu, \sigma^2)$ $\gamma_n(\bar{x};\gamma_n\sigma_0^2)$ rage cost is the weighted mean of two values c_0 $X \sim Bin(n, p)$ Beta(a + x, b +and c_1 is $c_0 \pi_0 P(X \in R|H_0) + c_1 \pi_1 P(X \notin R|H_1) =$ $c_1\pi_1 + \int_{\mathbb{R}} (c_0\pi_0 f(x|\theta_0) - c_1\pi_1 f(x|\theta_1)) dx$. It fol- $(X_1, \dots, X_r) \sim (p_1, \dots, p_r) \sim M n(n; p_1, \dots, p_r)$ $Dir(\alpha_1, \dots, \alpha_r)$ $Dir(\alpha_1)$ $x_1, \cdots, \alpha_r + x_r$ lows that the rejection region minimising the ave-Beta(a+n,b+ X_1, \cdots, X_n Geom(p)rage cost is $R = \{x : c_0 \pi_0 f(x|\theta_0) < c_1 \pi_1 f(x|\theta_1)\}.$ Beta(a,b)Thus the optimal decision rule becomes to $Gam(\alpha_0)$ reject H_0 for small values of the likelihood ratio $Pois(\mu)$ $n\bar{x}, \lambda_0 + n$ when $\frac{f(x|\theta_0)}{f(x|\theta_1)} < \frac{c_1\pi_1}{c_0\pi_0}$ or for small posterior odds, $Gam(\alpha_0)$ $\alpha n, \lambda_0 + n\bar{x}$ posterior pseudo-counts = prior pseudocounts plus sample counts VI Summarising data Normal-Normal model Shrinkage factor-1. Empirical probability distribution Empirical distr. fn. $\hat{F}(x) = \frac{1}{n} \sum_{i=1}^{n} 1_{\{x_i \le x\}}$. If the data describes life lengths, then it is mo- Binomial-Beta modelre convenient to use the empirical survival fn. Simple demonstration that beta distribution gives a conjugate prior to the binomial likelihood. $\hat{S}(x) = 1 - \hat{F}(x)$, the proportion of the data $prior \propto p^{a-1}(1-p)^{b-1}$ greater than x. If the life length T has distr. fn. $F(t) = P(T \le t)$, then its survival function is $likelihood \propto p^{x}(1-p)^{n-x}$ S(t) = P(T > t) = 1 - F(t). Hazard function posterior ∝ prior × likelihood ∝ $p^{a+x-1}(1-p)^{b+n-x-1}$. $h(t) = \frac{f(t)}{S(t)}$ where f(t) = F(t) is the probabi-2. Bayesian estimation lity density fn. The hazard fn. (also known as In terms of decision theory, we are loothe failure rate, hazard rate, or force of mortaking for an optimal action action a = lity) is the ratio of the probability density func-{assignvalueatounknownparameterθ} tion to the survival fn. The hazard function is The optimal a depends on the choice of the mortality rate at age t: $P(t < T \le t + \delta | T \ge t)$ the loss function $l(\theta, a)$. Bayes action mi- $\frac{P(t < T \le t + \delta)}{P(T \ge t)} = \frac{F(t + \delta) - F(t)}{S(t)} \sim \delta h(t), \delta \to 0.$ nimises posterior risk $R(a|x) = E(l(\Theta, a)|x)$ The hazard function can be viewed as the neso that $R(a|x) = \int l(\theta, a)h(\theta|x)d\theta$ or gative of the slope of the log survival fn: h(t) = $R(a|x) = \sum_{\theta} l(\theta, a)h(\theta|x)$. There are 2 loss $-\frac{d}{dt}\ln S(t) = -\frac{d}{dt}\ln(1-F(t))$. A constant hazard fns leading to two Bayesian estimators. rate $h(t) = \lambda$ corresponds to the exponential dis-1. Zero-one loss fn and max a posteriori probabitribution $E x p(\lambda)$. Zero-one loss fn: $l(\theta, a) = 1_{\theta \neq a}$ 2. Density estimation 3. Quantiles and QQ-plots Using zero-one loss fn., the posterior risk is $R(a|x) = \sum_{\theta \neq a} h(\theta|x) = 1 - h(a|x)$. It follows that to minimise the risk we have to maximise the posterior probability. We define $\hat{\theta}_{map}$ as the dots with coordinates $(x_{(k)}, y_{(k)})$. value of θ that maximises $h(\theta|x)$. Observe that 4. Testing normality with the uninformative prior, $\hat{\theta}_{map} = \hat{\theta}_{mle}$. • Coefficient of skewness: $\beta_1 = \frac{E(X-\mu)^3}{\sigma^3}$, sample 2. Squared error loss function and posterior Squared error loss: $l(\theta, a) = (\theta - a)^2$ Using squared error loss function, the posterior risk is $R(a|x) = E((\Theta - a)^2|x) =$ $Var(\Theta|x) + [E(\Theta|x) - a]^2$. Since the first component is independent of a, we minimise the posterior risk by putting $\hat{\theta}_{pme} = E(\Theta|x)$. • Multinomial Dirichlet- 2 Bayesian estimates-1. Prior- $\hat{\theta}_{map} = \hat{\theta}_{mle} = (\frac{\alpha_1}{\alpha_1 + \alpha_r}, \cdots, \frac{\alpha_r}{\alpha_1 + \alpha_r})$ 2. Posterior mean estimate- $\hat{\theta}_{pme}$ 3. Credibility interval • Let x be the data. For a confidence interval formula $I_{\theta} = (a_1(x), a_2(x))$, the parameter θ is distr: β_2 < 3 (light tails). 5. Measures of location

Treating ϕ as a constant and the Bayes for- is random $P(a_1(X) < \Theta < a_2(X)) = 1 - \alpha$. A mula can be summarised as posterior \propto credibility interval $J_{\theta} = (b_1(x), b_2(x))$ is treated

likelihood×prior.

• Beta distribution- $f(p) = \frac{\Gamma(a+b)}{\Gamma(a)\Gamma(b)} p^{a-1} p^{b-1}, 0 <$

p < 1 with mean and variance $\mu = \frac{a}{a+b}$, $\sigma^2 =$

1. Conjugate priors

VII Comparing two samples

as a nonrandom interval, while θ is generated by

the posterior distribution of a random variable Θ .

A credibility interval is computed from the poste-

rior distribution $P(b_1(x) < \Theta < b_2(x)|x) = 1 - \alpha$.

4. Bayesian hypotheses testing

For a given distr. F and $0 \le p \le 1$, the p-quantile is $x_p = Q(p)$. $x_{(k)}$ is called the empirical $(\frac{k-0.5}{n})$ quantile.. QQ-plot is a scatter plot of n two means- If n and m are large, we can use a

skewness: $b_1 = \frac{1}{s^3 n} \sum_{i=1}^n (x_i - \bar{x})^3$. Depending on the sign of the coefficient of skewness with distinguish between symmetric $\beta_1 = 0$, skewed to the right $\beta_1 > 0$, and skewed to the left $\beta_1 < 0$ • Kurtosis $\beta_2 = \frac{E(X-\mu)^4}{\sigma^4}$, sample kurtosis: $b_2 = \frac{1}{s^4 n} \sum_{i=1}^n (x_i - \bar{x})^4$. Kurtosis is a measure of

the peakedness of the probability distribution of a real-valued random variable, although some sources are insistent that heavy tails, and not peakedness, is what is really being measured by Kurtosis. For the normal distribution, kurtosis coefficient takes value $\beta_2 = 3$. Leptokurtic distribution: $\beta_2 > 3$ (heavy tails). Platykurtic

is an unbiased estimate of the variance with

 $I_m = (x_{(k)}, x_{(n-k+1)})$ is a 100 p_k % c.i. for the pop. Exact distribution $\frac{(\bar{X}-\bar{Y})-(\mu_1-\mu_2)}{S_n}\sqrt{\frac{nm}{n+m}} \sim$

• Sample median $\hat{m} = x_{(k)}$, if n = 2k - 1, and variance $Var(\bar{X} - \bar{Y}) = \sigma^2 \frac{n+m}{nm}$ has the fol-

null distributions of W_{\perp} & W_{\perp} are the same and t_{n+m-2} . Exact confidence interval formula • sign test The sign test is a non-parametric $I_{\mu_1 - \mu_2} = \bar{x} - \bar{y} \pm t_{n+m-2} (\alpha/2) s_p \sqrt{\frac{n+m}{nm}}$. Two samtest of H_0 : $m = m_0$ against the two-sided one can use the normal approximation of the alternative $H_0: m \neq m_0$. The sign test statistic null distr. with mean and var. $\mu_W = \frac{n(n+1)}{4}$ & ple t-test uses the test statistic $t = \frac{\bar{x} - \bar{y}}{s_n} \sqrt{\frac{nm}{n+m}}$ $y_0 = \sum_{i=1}^n 1_{\{x_i \le m_0\}}$ counts the number of obser- $\sigma_W^2 = \frac{n(n+1)(2n+1)}{24}$. The signed rank test uses for testing H_0 : μ_1 = μ_2 . The null distribution of vations below the null hypothesis value. It has a simple null distribution $Y_0 \sim^{H_0} Bin(n, 0.5)$. Connection to the above c.i formula: reject H_0 if m_0 falls outside the corresponding c.i. Rank sum test-It is a nonparametric test for requires symmetric distribution of differences. two indep, samples, which does not assume 4. External and confounding factors normality of pop. distr. Assume continuous placebo effect population distributions F_1 and F_2 , and consider H_0 : $F_1 = F_2$ against H_1 : $F_1 \neq F_2$. The rank sum test procedure: pool the samples and replace

lowing unbiased estimate $s_{\bar{x}-\bar{y}}^2 = s_p^2 \frac{n+m}{nm}$.

• trimmed means- α -trimmed mean \bar{x}_{α} = sample mean without $\frac{n\alpha}{2}$ smallest and $\frac{n\alpha}{2}$ largest the data values by their ranks $1, 2, \dots, n + m$ starting from the smallest sample value to the • Nonparametric bootstrap- Substitute the largest, and then compute two test statistics $r_1 =$ population distribution by the empirical distrisum of x-ranks, and r_2 = sum of y-ranks. Clearly bution. Then a bootstrap sample is obtained by $r_1 + r_2 = 1 + 2 + \dots + (n + m) = \frac{(n+m)(n+m+1)}{2}$. The resampling with replacement from the original sample (x_1, \dots, x_n) . Generate many bootstrap null distr. for R_1 and R_2 depend only on the samples of size n to approximate the sampling sample sizes n and m. For $n \ge 10$, $m \ge 10$, apply distribution for an estimator like trimmed mean, the normal approximation for the null distr. of R_1 and R_2 with $E(R_1) = \frac{n(n+m+1)}{2}$, $E(R_2) = \frac{m(n+m+1)}{2}$, $Var(R_1) = Var(R_2) = \frac{mn(n+m+1)}{12}$. The difference between non parametric bootstrap and parametric bootstrap is that parametric is with the normality assumption, and non 2. Two indep. samples: comparing population parametric is without the normality assumption. For $X \sim Bin(n, p_1)$, $Y \sim Bin(m, p_2)$, unbiased est. of p_1 & p_2 are $\hat{p}_1 = \frac{x}{n}$ & $\hat{p}_2 = \frac{y}{m}$ which have standard errors $s_{\hat{p}_1} = \sqrt{\frac{\hat{p}_1(1-\hat{p}_1)}{n-1}} \& s_{\hat{p}_2} = \sqrt{\frac{\hat{p}_2(1-\hat{p}_2)}{m-1}}$ • We wish to compare 2 pop. distr. with means Large sample test for two proportionsand std. dev. (μ_1, σ_1) , (μ_2, σ_2) based on 2

If the samples sizes m and n are lar-

ge, then an approx. c.i for $p_1 - p_2$ is

the null hypothesis H_0 : $p_1 = p_2$ when the sample

sizes m and n are not sufficiently large for apply-

ing normal approximations for the binomial distr.

Fisher's idea for this case, was to use X as a test

statistic conditionally on the total number of

successes x + y. Under the null hypothesis,

the conditional distr. of X is hypergeometric

 $X \sim Hg(N, n, p)$ with parameters (N, n, p)

distr. with prob. mass fn. $P(X = x) = \frac{\binom{Np}{x}\binom{Nq}{n-x}}{\binom{N}{x}}$

Sample

Np=x+y

Sample

Number

of succes-

Number

of failures

Sample si-

 $I_{p_1-p_2} = \hat{p}_1 - \hat{p}_2 \pm 1.96 \sqrt{\frac{\hat{p}_1(1-\hat{p}_1)}{n-1} + \frac{\hat{p}_2(1-\hat{p}_2)}{m-1}}.$ We can test the null hypothesis of equality H_0 : their std errors $s_{\bar{x}} = \frac{s_1}{\sqrt{n}}, s_1^2 = \frac{1}{n-1} \sum_{i=1}^{n} (x_i - \bar{x})^2$ $p_1 = p_2$ 3. Paired samples & $s_{\bar{y}} = \frac{s_2}{\sqrt{m}}, s_2^2 = \frac{1}{m-1} \sum_{i=1}^{m} (y_i - \bar{y})^2$. Diff. $\bar{x} - \bar{y}$ is Fisher's exact test-Fisher's exact test deals with

then $Var(\bar{X} - \bar{Y}) = \sigma_{\bar{Y}}^2 + \sigma_{\bar{Y}}^2 = \frac{\sigma_1^2}{n} + \frac{\sigma_2^2}{m}$ & $s_{ ilde{X}- ilde{Y}}^2=s_{ ilde{X}}^2+s_{ ilde{Y}}^2=rac{s_1^2}{n}+rac{s_2^2}{m}$ gives an unbiased estimate of $Var(\bar{X} - \bar{Y})$. • Large sample test for the difference between

iid-samples (x_1, \dots, x_n) and (y_1, \dots, y_m) from

these 2 pop. Two sample means \bar{x} , \bar{y} and

an unbiased est. of $\mu_1 - \mu_2$. We are interested

in finding the std. error of $\bar{x} - \bar{y}$ & an interval

est, for $\mu_1 - \mu_2$ & testing the null hypothesis of equality $H_0: \mu_1 = \mu_2$.

1. Two indep. samples: comparing pop. means If (X_1, \dots, X_n) is indep. from (Y_1, \dots, Y_m) ,

 $\hat{m} = \frac{x_{(k)} + x_{(k+1)}}{2}$, if n = 2k.

 $I_m = (x_{(k)}, x_{(n-k+1)})$.

6. Measures of dispersion

median m.

normal approximation $\frac{\bar{X} - \bar{Y} - (\mu_1 - \mu_2)}{S_{\bar{X}}^2 + S_{\bar{Y}}^2} \approx N(0, 1).$ The hypothesis $H_0: \mu_1 = \mu_2$ is tested using the = whose null distribution

is approximated by the standard normal N(0,1). Approximate confidence interval formula- $I_{\mu_1 - \mu_2} = \bar{x} - \bar{y} \pm z_{\alpha/2} \sqrt{s_{\bar{x}}^2 + \overline{s_{\bar{v}}^2}}$ • Two-sample t-test The key assumption of the

 $N(\mu_1, \sigma^2)$, $Y \sim N(\mu_2, \sigma^2)$ have equal variances. Given $\sigma_1^2 = \sigma_2^2 = \sigma^2$, the pooled sample variance $\sum_{i=1}^{n} (x_i - \bar{x})^2 + \sum_{i=1}^{m} (y_i - \bar{y})^2$

 $E(S_n^2) = \frac{n-1}{n+m-2}E(S_1^2) + \frac{m-1}{n+m-2}E(S_2^2) = \sigma^2$. In the equal variance two sample setting, the

distr. should be used for determining the rejectitwo-sample t-test: two normal pop. distr. $X \sim$ on rule of the Fisher test. Signed rank test The sign test disregards a lot of information in the data taking into account only the sign of the differences. The signed rank test pays attention to sizes of positive and negative differences. This is a non-parametric test for the null hypothesis of no diff. H_0 : distr. of D is symmetric about its median m = 0. The null hypothesis consists of two parts: symmetry of the distr. and m = 0. Test

VIII Analysis of variance 1-wav ANOVA 2-way ANOVA A test that allows A test that allows one to make

comparisons

comparisons

statistics: either $w_+ = \sum_{i=1}^n rank(|d_i|).1_{d_i>0}$ or

 $w_{-} = \sum_{i=1}^{n} rank(|d_i|).1_{d_i < 0}$. Assuming no ties,

that is $d_i \neq 0$, we get $w_+ + w_- = \frac{n(n+1)}{2}$. The

tabulated for smaller values of n. For n > 20.

more data information than the sign test but

between between means of 3 or means of 3 or more groups of more groups of data, where two independent variables are considered. dep. var. What is The effect of The means of multiple groups being three or more groups of an of two indep. variables independent pared variable dependent dependent variable and on variable. each other. Three or more. Each variable groups should have mulof samp tiple samples. les $Y_{ij} = \mu + \alpha_i + \epsilon_{ij}, \sum_i \alpha_i = 0, \epsilon_{ij} \sim N(0, \sigma^2).$ Using the maximum likelihood approach, the point estimates are $\hat{\mu} = \bar{y}_{..}$, $\hat{\mu}_i = \bar{y}_i$, $\hat{\alpha}_i = \bar{y}_i - \bar{y}_{..}$ where $\bar{y}_{i.} = \frac{1}{J} \sum_{i} y_{ij} \& \bar{y}_{..} = \frac{1}{I} \sum_{i} y_{i.}$. It follows

1. One-way layout $Y = \mu(X) + \epsilon, E(\epsilon) = 0$ Normal theory model

that $y_{ij} = \hat{\mu} + \hat{\alpha}_i + \hat{\epsilon}_{ij}, \hat{\epsilon}_{ij} = y_{ij} - \bar{y}_{i,j}, \sum_{i=1}^{I} \hat{\alpha}_i = 0$ One-way F-test The pooled sample var. $s_n^2 = MS_E$ is an unbiased

Step 1: Set up hypotheses and determine level of

Consider I levels of the main factor A each

of sample size I. Degrees of freedom are

 $df_1 = I - 1 = n_1 \& df_2 = I(J - 1) = n_2$. Critical

Nq=n+m-significance H_0 : $\mu_1 = \dots = \mu_I$, H_1 : Means are not $\frac{x-y}{a}$ all equal $\mu_u \neq \mu_v$, state α . Step 2: Select the appropriate test statistic. The test statistic is the F statistic for Anova,

Step 3: Set up decision rule.

value F_{n_1,n_2} can be found from F distr. table. defined by N = n + m, $p = \frac{x+y}{N}$. This is a discrete Decision rule is: Reject H_0 if $F > F_{n_1,n_2}$. Step 4. Compute the test statistic. One-way Anova table. Source | $max(0, n - Nq) \le x \le min(n, Np)$. This null Varia-

Sums of Squares | Deg. | Mean Free- $SS_A = J \sum (\bar{y}_{i.} MS_A = F = \frac{MS_A}{MS_F}$ $\frac{SS_A}{df_A}$ Error $MS_E =$ $SS_T = \sum_i \sum_j (y_{ij} - y_{ij})$

 $\bar{y}_{...}$)² = $SS_A + SS_E$ 2. Simultaneous confidence interval $100(1-\alpha)\%$ simultaneous c.i. for a single pair of Here, $SS_A = JK\sum_i(\bar{y}_{i,..} - \bar{y}_{...})^2 \& SS_B$ $IK\sum_{i}(\bar{y}_{.j.} - \bar{y}_{...})^{2} \& SS_{A*B} = K\sum_{i}\sum_{i}(\bar{y}_{ij.} - \bar{y}_{...})^{2}$ indep. samples $I_{\mu_u-\mu_v}=\bar{y}_u-\bar{y}_v\pm t_{df}(\frac{a}{2})s_p\sqrt{\frac{2}{J}}$. The multiple comparison problem: the above confidence interval formula is aimed at a single $\bar{y}_{i..} - \dot{\bar{y}}_{i..} + \bar{y}_{...}^2 \& SS_E = \sum (y_i - \bar{y}_{ij})^2$ The mean sums of squares and their expected difference, and may produce false discoveries.

Bonferroni method

Tukev method

3. Kruskal-Wallis test

4. Two-way layout

the grand mean,

 $\& \sum_{i=1}^{J} \delta_{ij} = 0$

Normal theory model

 $\delta_{ij} = \bar{y}_{ij.} - \bar{y}_{i..} - \bar{y}_{.j.} + \bar{y}_{...}$

Source SS df

Main Effect A

Main Effect B

Error

Bonferroni method is a statistical test repeatedly applied to k independent samples of size n. The

 $B_{\mu_u - \mu_v} = \bar{y}_u - \bar{y}_v \pm t_{df}(\frac{\alpha}{2k}) s_p \sqrt{\frac{2}{I}}, 1 \le u < v \le I$

where df = I(J-1) and $k = \frac{I(I-1)}{2}$. Bonferroni

method gives slightly wider intervals compared to the Tukey method.

If I independent samples $(y_{i1},...,y_{iJ})$ taken

from $N(\mu_i, \sigma^2)$ have the same size J, then

 $Z_i = \bar{Y}_{i.} - \mu_i \sim N(0, \frac{\sigma^2}{I})$ are independent.

Consider the range of differences between Z_i : $R = max\{Z_1,...,Z_I\} - min\{Z_1,...,Z_I\}$. The normalised range has a distribution that is free from

the parameter $\sigma \frac{R}{S_n \sqrt{J}} \sim SR(I, df), df = I(J-1).$

Tukey's $100(1-\alpha)\%$ simultaneous confidence in-

terval is given by $T_{\mu_u-\mu_v} = \bar{y}_{u.} - \bar{y}_{v.} \pm q_{I,df}(\alpha) \frac{s_p}{\sqrt{I}}$.

A nonparametric test, without assuming norma-

lity, for no treatment effect H_0 : all observations

are equal in distribution. Extending the idea

of the rank-sum test, consider the pooled sample of size N = IJ. Let r_{ij} be the poo-

led ranks of the sample values y_{ij} , so that

 $\sum_{i} \sum_{j} r_{ij} = 1 + 2 + ... + N = \frac{N(N+1)}{2}$ where the

mean rank is $\bar{r}_{...} = \frac{(N+1)}{2}$. Kruskal-Wallis test

statistic is given by $W = \frac{12J}{N(N+1)} \hat{\sum} (\bar{r}_{i.} - \frac{N+1}{2})^2$

Reject H_0 for large W using the null distribution table.

 $\mu(x_{1i}, x_{2j}) = \mu_{ij} = \mu + \alpha_i + \beta_j + \delta_{ij}$ where μ is

 δ_{ij} is the AB-interaction effect, with $\sum_{i=1}^{I} \delta_{ij} = 0$

 $Y_{ijk} = \mu + \alpha_i + \beta_j + \delta_{ij} + \epsilon_{ijk}, i = 1, \dots, I, j = 0$

 $\hat{\epsilon}_{ijk} = y_{ijk} - \bar{y}_{ij.}$. Three F-tests-

 $\frac{SS_B}{df_B}$

 $\frac{MS_{A*B}}{MS_F}$

 $1, \dots, J, k = 1, \dots, K$ where $\epsilon_{ijk} \sim N(0, \sigma^2)$

IJ(K-1)

 α_i is the main A-effect, $\sum_{i=1}^{I} \alpha_i = 0$

 β_j is the main B-effect, $\sum_{j=1}^{J} \beta_j = 0$

values $E(MS_A) = \sigma^2 + \frac{JK}{I-1} \sum_i \alpha_i^2$ $E(MS_B) = \sigma^2 + \frac{IK}{I-1} \sum_i \beta_i^2$

 $E(MS_{AB}) = \sigma^2 + \frac{K}{(I-1)(I-1)} \sum_{i} \sum_{i} \delta_{i,i}^2$ overall significance level α is obtained, if each single test is performed at significance level $E(MS_F) = \sigma^2$ $\alpha_0 = \alpha/k$. Assuming the null hypothesis is true, 6. Randomised block design the number of positive results is $X \sim Bin(k, \alpha_0)$. Blocking is used to remove the effects of the most Thus for small values of α_0 , $P(X \ge 1 \mid H_0) =$ $1-(1-\alpha_0)^k \approx k\alpha_0 = \alpha$. This gives Bonferroni's $100(1-\alpha)\%$ simultaneous confidence interval

important nuisance variable. Randomisation is then used to reduce the contaminating effects of the remaining nuisance variables. Experimental design: randomly assign I treat ments within each of J blocks. Test the null hypothesis of no treatment effect using the two-way layout Anova. The block effect is anticipated and is not of

major interest. Additive model Mean of Free-Sqs. (MS) Variadom

 $F = \frac{MS_A}{MS_E}$ Main $SS_A = J \sum_i (\bar{y}_i)$ I-1 MS_A $\frac{SS_A}{df_A}$ $MS_B =$ $F = \frac{MS_B}{MS_E}$ $SS_B = I \sum_i (\bar{y}_{.i} -$ I-1 $\frac{SS_B}{df_B}$ Error $SS_E = \sum_i \sum_j (y_{ij})$ MS_E $\frac{SS_E}{df_E}$ $SS_T = \sum_i \sum_j (\bar{y}_{ij})$ $\bar{y}_{SS}^{(1)} = SS_A + SS_A +$ $E(MS_A) = \sigma^2 + \frac{J}{J-1} \sum_i \alpha_i^2$

 $E(MS_B) = \sigma^2 + \frac{I}{I-1} \sum_i \beta_i^2$

 $E(MS_F) = \sigma^2$

7. Friedman test

Here we introduce another nonparametric test, which does not require that $\hat{\epsilon}$ ij are normally distributed, for testing H_0 : no treatment effect. The Friedman test is based on within block ranking. Let ranks within j-th block be: (r_{ij}, \dots, r_{Ii}) =ranks of (r_{ij}, \dots, r_{Ii}) so that $r_{1j} + \dots + r_{Ij} = 1 + 2 + \dots + I = \frac{I(I+1)}{2}$ where $\frac{1}{I}(r_{1,i}+\cdots+r_{I,i})=\frac{I+1}{2}$ and $\bar{r}_{i}=\frac{(I+1)}{2}$. Friedman

• Observed countsapproximate null distribution $Q \sim \chi_{l-1}^2$ Reject H_0 for large W using the null distribution table.

IX Categorical data analysis 1. Chi-squared test of homogeneity

Consider a table of I × J observed counts obtd. from J indep. samples taken from J pop. distr.: Pop. 1 Pop. 2 ··· Pop. J Total |

Category 2	n_{21}	n_{22}	• • • •	n_{2J}	$n_{2.}$
Category I	n_{I1}	n_{I2}	•••	n_{IJ}	$n_{I.}$
ample sizes	$n_{.1}$	$n_{.2}$		$n_{.J}$	n_{I}
is model is described by J multinomial dis-					
$(N_{1j}, \dots, N_{1j}) \sim Mn(n_{.j}; \pi_{1 j}, \dots, \pi_{I j}), j =$					
·· , J Under the hypothesis of homogeneity					
: $\pi_{i j} = \pi_i, \forall (i,j)$, the m.l.e of π_i are the					
oled sample proportions $\hat{\pi_i} = \frac{n_i}{n}$, $i = 1, \dots, I$.					
ing m.l.e, we compute the expected cell					
unto $E = n \neq n_i, n_j \neq 1$					

& the chi-squared test statistic becomes

 $\chi^2 = \sum_{i=1}^{I} \sum_{j=1}^{J} \frac{(n_{ij} - n_{i.} n_{i.} / n_{..})^2}{n_{i.} n_{i.} / n_{..}}$ We reject H_0 for large values of $\chi^2 \& df = (I-1)(J-1)$. 2. Chi-squared test of independence

Data: a single cross-classifying sample is summarised in terms of the observed counts, whose joint distribution is multinomial $(N_{1j}, \dots, N_{1j}) \sim$ $Mn(n_{,i}; \pi_{1|i}, \dots, \pi_{I|i}), j = 1, \dots, J$ Under the hypothesis of homogeneity $H_0: \pi_{i|j} = \pi_i, \forall (i, j),$ the m.l.e of π_i are the pooled sample proportions $\hat{\pi_i} = \frac{n_i}{n}, i = 1, \dots, I$. Using m.l.e,

McNemar's test

we compute the expected cell counts $E_{ij} = n_{.j} \hat{\pi}_i = \frac{n_{i.} n_{.j}}{n}, i = 1, \dots, I \& \text{the chi-squared}$ test statistic becomes $\chi^2 = \sum_{i=1}^I \sum_{j=1}^J \frac{(n_{ij} - n_{i.} n_{i.} / n_{..})^2}{n_{i.} n_{i.} / n_{..}}$ We reject H_0 for large values of χ^2 & df = (I-1)(J-1). 3. Matched-pairs designs

Consider obtd. matcheddata by for design pop. unaffected X unaffected \bar{X} Null hypothesis H_0 : $p_{12} = p_{21} = p$ This yields the

McNemar's test statistic: $\chi^2 = \frac{(m_{12} - m_{21})^2}{m_{12} + m_{21}}$ whose approx. null distr. is χ_1^2 4. Odds ratios

Conditional odds for A given B are de-

fined as odds(A|B) =

Odds ratio for a pair of events defined by $\Delta_{AB} = \frac{odds(A|B)}{odds(A|\bar{B})} = \frac{P(AB)P(\bar{A}\bar{B})}{P(\bar{A}B)P(A\bar{B})}$. The odds ratio is a measure of dependence between a pair of random events having the following properties $\frac{B_i - \beta_i}{S_{B_i}} \sim t_{n-2}$. if $\Delta_{AB} = 1$, then events A and B are independent,

if $\Delta_{AB} < 1$, then $P(A|B) < P(A|\bar{B})$ & so B dec. prob. of A. Odds ratios for case-control studies Conditional probabilities-

Total P(X|D) $P(\bar{X}|D)$ $P(X|\bar{D})$ $P(\bar{X}|\bar{D})$ $\frac{P(X|D)P(\bar{X}|\bar{D})}{P(\bar{X}|D)P(X|\bar{D})}$ Corresponding odds ratio Δ_{DX} =

> Total n_{11} n_{12} n_{1} n_{22}

X Multiple regression

 Simple linear regression has only one x and one y variable. Multiple linear regression has one v and two or more x variables. For instance, when we predict rent based on square feet alone that is simple linear regression. When we predict rent based on square feet and age of the building that is an example of multiple linear regression.

1. Simple linear regression model A simple linear regression model connects two random vars (X,Y): X is called predictor variable and Y is called response by a linear relation counts $E_{ij} = n_{.j}\hat{\pi}_i = \frac{n_{i.}n_{.j}}{n_{..}}, i = 1, \dots, I$ $Y = \beta_0 + \beta_1 X + \epsilon, \epsilon \sim N(0, \sigma^2)$ where ϵ is the $y_1 = \beta_0 + \beta_1 x_{1,1} + \dots + \beta_{p-1} X_{1,p-1} + e_1$ noise. The key assumption of the model requires

that has a normal distribution $N(0, \sigma^2)$ indep. of $y_n = \beta_0 + \beta_1 x_{n,1} + \dots + \beta_{p-1} X_{n,p-1} + e_n$ X. This assumption is called homoscedasticity, meaning that the noise size σ is the same for all possible levels of the predictor var. The fitted regression line is

 $y = b_0 + b_1 x = \bar{y} + r \frac{s_y}{s_x} (x - \bar{x})$ where sample correlation coefficient is $r = \frac{s_{xy}}{s_x s_y}$

 $s_{xy} = \frac{1}{n-1} \sum (x_i - \bar{x})(y_i - \bar{y}).$ 2. Residuals

Then the size of noise (estimated σ^2) is $s^2 = \frac{n-1}{n-2} s_v^2 (1-r^2).$

standardised residuals $\frac{\hat{e}_i}{s\sqrt{1-p_{ii}}}$ where p_{ii} are the Decomposition: $y_i - \bar{y} = \hat{y}_i - \bar{y} + \hat{e}_i$ implies $SS_T = SS_R + SS_E$ $R^2 = 1 - \frac{SS_E}{SS_T}$, $SS_T = (n-1)s_v^2$. Adjusted coefficient of multiple determination $R_a^2 = 1 - \frac{n-1}{n-p} \frac{SS_E}{SS_T} = 1 - \frac{s^2}{s_E^2}$. The adjustment factor

 $SS_T = \sum_i (y_i - \bar{y})^2 = (n-1)s_y^2$ $SS_R = \sum_i (\hat{y}_i - \bar{y})^2 = (n-1)b_1^2 s_r^2$ $SS_E = \overline{S(b_0, b_1)} = \sum_i (y_i - \hat{y}_i)^2 = (n-1)s_v^2(1-r^2).$

Combining them, $r^2 = \frac{SS_R}{SS_T} = 1 - \frac{SS_E}{SS_T}$. Thus the squared sample correlation coefficient r^2 is called the coefficient of determination. Coefficient of determination r^2 is the proportion of variation in the response variable explained by the variation of the predictor. r^2 is independent of choice of the explanatory and the response To test the normality assumption, use the normal distribution plot for the standardised residuals

look as a horizontal blur. Non-linearity problem is fixed by log-log transformation of the data. 3. Confidence intervals and hypothesis testing $i = 0, 1, B_i \sim N(\beta_i, \sigma_i^2), s_{b_i}^2 = \frac{s^2 \sum x_i^2}{n(n-1)s_i^2}$

if $\Delta_{AB} > 1$, then $P(A|B) > P(A|\bar{B})$ & so B inc. Exact $100(1-\alpha)\%$ c.i. $I_{\beta_i} = b\,i \pm t_{n-2}(\frac{\alpha}{2})s_{b_i}$. Prob. of A, Test statistic $t = \frac{b_i - \beta i}{s_b}$ that has the exact null 4. Intervals for individual observations

• In cases where we assume a model with an

of Y for a given X falls with a certain probability. Thus the prediction interval is always wider than the confidence interval for a given signficance

Corresponding odds ratio $\hat{\Delta}_{DX} = \frac{n_{11} n_{22}}{n_{12} n_{21}}$

 $t_{n-2}(\frac{\alpha}{2})s\sqrt{1+\frac{1}{n}+\frac{1}{n-1}(\frac{x-\bar{x}}{s_x})^2}$ Prediction interval has wider limits since it

Exact prediction interval $I_{tt} = b_0 + b_1 x \pm b_2$

contains the uncertainty due the noise factors: $Var(Y - \hat{\mu}) = Var(\mu + \epsilon - \hat{\mu}) = \sigma^2 + Var(\hat{\mu}) =$

 $\sigma^2(1+\frac{1}{n}+\frac{1}{n-1}(\frac{x-\bar{x}}{s_x})^2)$ 5. Linear regression and ANOVA

6. Multiple linear regression

 $t_{n-2}(\frac{\alpha}{2})s\sqrt{\frac{1}{n}+\frac{1}{n-1}(\frac{x-\bar{x}}{s_x})^2}$

Multiple linear regression model: Y = $\beta_0 + \beta_1 X_1 + \dots + \beta_{p-1} X_{p-1} + \epsilon, \ \epsilon \sim N(0, \sigma^2)$ Corr. data set consists of n indep. vectors with n > p is

 $\frac{n-1}{n-p}$ gets larger for the larger values of predictors p. Basic probability theory

An unbiased estimate of σ^2 is $s^2 = \frac{SS_E}{n-p}$ where

 $SS_E = ||\hat{e}||^2 = ||y - \hat{y}||^2$. To check the underlying normality assumption

inspect the normal probability plot for the

Coefficient of multiple determination

• Cumulative distribution function $F(x) = P(X \le x) = \sum_{y \le x} f(y) o r = \int_{y \le x} f(y) dy$

- Expected value (mean or average) of X $\mu = E(X) = \sum_{x} f(x) \circ r = \int_{x} f(x) dx$
- $Var(cX) = c^2 Var(X)$ • $Var(\overline{X}) = E(\overline{X}^2) - (E(\overline{X}))^2$
- Standard normal distribution $Z \sim N(0,1)$
- $\tilde{e}_i = \frac{\hat{e}_i}{s_i}, i = 1, \dots, n \text{ where } s_i = s \sqrt{1 \frac{\sum_k (x_k x_i)^2}{n(n-1)s^2}}$ has the density fn. and distribution For simple linear regression model, scatter plot

Design matrix

 $1 \ x_{1,1} \cdots x_{1,p-1}$

 $1 x_{n,1} \cdots x_{n,p-1}$

diagonal elements of P.

- fn. $\phi(z) = \frac{1}{\sqrt{2\pi}}e^{-z^2/2} = \frac{1}{\sqrt{2\pi}}e^{-(\frac{X-\mu}{\sigma})^2/2}$, of the standardised residuals versus x_i should
 - $\phi(z) = \int_{-\infty}^{z} \phi(x) dx$ • Normal distribution $X \sim N(\mu, \sigma^2)$: $\frac{X-\mu}{\sigma} \sim N(0,1), \ f(x) = \frac{1}{\sigma} \phi(\frac{x-\mu}{\sigma}), \ E(X) = \mu,$
 - Discrete uniform distribution $X \sim U(N)$:
 - $f(k) = \frac{1}{N}, 1 \le k \le N, E(X) = \frac{N+1}{2}, Var(X) =$
 - Continuous uniform distribution $X \sim U(a, b)$: $f(k) = \frac{1}{b-a}, a < x < b, E(X) = \frac{a+b}{2}, Var(X) =$
- explanatory variable X and a response variable Y. • Binomial distribution $X \sim Bin(n, p)$: the prediction interval is an interval in which a $f(k) = \binom{n}{k} p^k (1-p)^{n-k}, 0 \le k \le n, E(X) =$
- single sample of Y falls with a certain probability np, Var(X) = np(1-p)• Bernoulli distribution Ber(p) = Bin(1, p)for a given X. In this context, a confidence interval corresponds to an interval which the mean
 - Geometric distribution $X \sim Geom(p)$:
 - $f(k) = pq^{k-1}, k \ge 1, E(X) = \frac{1}{p}, Var(X) = \frac{1-p}{p^2}$
- Exponential distribution $X \sim E x p(\lambda)$: $f(x) = \lambda e^{-\lambda x}, x > 0, E(X) = \sigma_X = \frac{1}{\lambda}$ Exact confidence interval $I_{\mu} = b_0 + b_1 x \pm$
 - Poisson distr. $X \sim Pois(\lambda)$:
 - $f(k) = \frac{\lambda^k}{k!} e^{-\lambda}, k \le 0, E(X) = Var(X) = \lambda$

The two-sample t-test assumes that two indetaken from two normal distributions with equal

variance. To test this normality assumption one may use a normal probability plot for n+m residuals $X_1 - \bar{X}, \dots, X_n - \bar{X}, Y_1 - \bar{Y}, \dots, Y_m - \bar{Y}$ Without taking account of multiple comparisons the CI is much narrower producing an excess of

false positive results. Multiple regression-The normality assumption can be justified in the case when the noise value is the sum of many independent and relatively small factors. Equal variance is realistic if the external factors are more or less the same across the three different experiments.